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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/705,218	11/12/2003	Keith Frank Best	081468-0306625	4107	
909 759	03/21/2006		EXAMINER		
PILLSBURY V	VINTHROP SHAW I	CHACKO DAVIS, DABORAH			
P.O. BOX 10500)				
MCLEAN, VA	22102		ART UNIT	PAPER NUMBER	
			1756		

DATE MAILED: 03/21/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Ap	pplication No.	Applicant(s)	U
		0/705,218	BEST ET AL.	
Office Action Sum	mary Ex	aminer	Art Unit	
		borah Chacko-Davis	1756	
The MAILING DATE of this Period for Reply	communication appears	s on the cover sheet with the	correspondence address	
A SHORTENED STATUTORY P WHICHEVER IS LONGER, FRO - Extensions of time may be available under t after SIX (6) MONTHS from the mailing date - If NO period for reply is specified above, the - Failure to reply within the set or extended p Any reply received by the Office later than the earned patent term adjustment. See 37 CF	M THE MAILING DATE the provisions of 37 CFR 1.136(a). of this communication. maximum statutory period will aperiod for reply will, by statute, caus three months after the mailing date	OF THIS COMMUNICATION In no event, however, may a reply be to ply and will expire SIX (6) MONTHS from the application to become ABANDON	N. imely filed in the mailing date of this communication. ED (35 U.S.C. § 133).	
Status			•	
<i>'</i> — · · ·	2b)⊠ This act condition for allowance	ion is non-final.'	rosecution as to the merits is 153 O.G. 213.	
Disposition of Claims				
4)⊠ Claim(s) <u>1-26</u> is/are pendir 4a) Of the above claim(s) _ 5)□ Claim(s) is/are allow 6)⊠ Claim(s) <u>1-26</u> is/are rejecte 7)□ Claim(s) is/are obje 8)□ Claim(s) are subjec	is/are withdrawn for wed. ed. cted to.			
Application Papers			iii.	
Replacement drawing sheet(s	is/are: a) ☐ accepte at any objection to the draw s) including the correction i	ving(s) be held in abeyance. S	ee 37 CFR 1.85(a). bjected to. See 37 CFR 1.121(d).	
Priority under 35 U.S.C. § 119				
2. Certified copies of the3. Copies of the certified	lone of: ne priority documents ha ne priority documents ha ed copies of the priority of International Bureau (Po	ive been received. Ive been received in Applica documents have been receiv CT Rule 17.2(a)).	tion No ved in this National Stage	
Attachment(s)				
 Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawin Information Disclosure Statement(s) (P Paper No(s)/Mail Date 11/03, 04/04. 		4) Interview Summal Paper No(s)/Mail I 5) Notice of Informal 6) Cther:		

Application/Control Number: 10/705,218

Art Unit: 1756

DETAILED ACTION

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 2. Claims 1-5, 8, 10-26, are rejected under 35 U.S.C. 102(b) as being anticipated by U. S. Patent No. 5,436,173 (Houston).

Houston, in the abstract, in col 3, lines 31-67, in col 4, lines 1-67, in col 5, lines 1-54, figures 1a through 1e, discloses forming a semiconductor device includes patterning a substrate (first substrate) on its first surface with alignment markers (trenches, reference 12), forming a protecting layer (insulating layer) over the alignment markers, bonding the substrate with alignment marks (first substrate) with another substrate (sécond substrate) and etching the insulating layer till the protective layer is exposed and forming trenches (references 18a, 18b, 18c) around the alignment markers, forming a patterned layer on the second surface of the first substrate (figure 1e) lithographically, and using the alignment marks to align the first alignment mark with that of the reverse alignment mark (claims 1, 4, 11, 14, 18, 19). Houston, in col 3, lines 45-67, discloses that the insulator layer (protective layer) perform as an etch stop and includes SiO₂ (oxides of dielectric or combination of dielectric material) (claims 2-3, 20). Houston, in col 5, lines 1-22, discloses that the prior to bonding a reflective layer is formed on the protective layer, and devices are formed on the reflective layer, wherein intervening

Art Unit: 1756

layers are selectively removed (utilizing etching and photolithographic techniques) (claims 5, 8, 10, 21-23). Houston, in col 3, lines 45-62, in col 4, lines 60-68, discloses forming the alignment marks and the corresponding reverse alignment marks photolithographically (claims 12, 16, 24). Houston, in col 4, lines 10-55, in col 7, lines 51-67, in col 8, lines 1-27, discloses photolithographically patterning and etching the etch resistant layer on the second surface of the first substrate to form openings (after removing the insulator layer) above the trench (see figure 4d) (claims 13, and 25). Houston, in col 5, lines 43-68, in col 6, lines 1-21, discloses etching the first substrate (using CMP) resulting in a reduction of thickness (claim 15). Houston, in col 6, lines 9-31, discloses forming at least one alignment marker that is positioned relative to the reverse alignment marker (on the second surface of the first substrate) revealed by the trenches (see figure 2h) (claims 17, and 26).

Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. Claims 6-7, and 9, are rejected under 35 U.S.C. 103(a) as being unpatentable over U. S. Patent No. 5,436,173 (Houston) in view of U. S. Patent No. 6,180,498 (Geffken et al., hereinafter referred to as Geffken).

Houston is discussed in paragraph no. 2.

Application/Control Number: 10/705,218

Art Unit: 1756

Houston, in the abstract, in col 3, lines 31-35, discloses forming a semiconductor device (claims 7, and 9).

The difference between the claims and Houston is that Houston does not disclose that the reflective layer is aluminum (claim 6).

Geffken, in col 2, lines 61-67, in col 3, lines 1-9, discloses that the reflective layer formed on the alignment mark area is an aluminum layer.

Therefore, it would be obvious to a skilled artisan to modify Houston by employing aluminum as the reflective layer as suggested by Geffken because Geffken, in col 5, lines 25-31, discloses that the aluminum reflective layer provides a substantial uniform optical background, and the edges of the aluminum layer provide contrast for alignment of the semiconductor.

Conclusion

5. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Daborah Chacko-Davis whose telephone number is (571) 272-1380. The examiner can normally be reached on M-F 9:30 - 6:00. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Mark F Huff can be reached on (571) 272-1385. The fax phone number for the organization where this application or proceeding is assigned is (571) 273-8300. Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For

Application/Control Number: 10/705,218

Art Unit: 1756

more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

dcd

March 14, 2006.

JOHN A. MCPHERSON PRIMARY EXAMINER Page 5